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SCDS157A-OCTOBER 2003-REVISED FEBRUARY 2005

#### **FEATURES**

- Member of the Texas Instruments Widebus™ **Family**
- Output Voltage Translation Tracks V<sub>CC</sub>
- **Supports Mixed-Mode Signal Operation on All** Data I/O Ports
  - 5-V Input Down to 3.3-V Output Level Shift With 3.3-V V<sub>CC</sub>
  - 5-V/3.3-V Input Down to 2.5-V Output Level Shift With 2.5-V V<sub>CC</sub>
- 5-V-Tolerant I/Os With Device Powered Up or **Powered Down**
- Bidirectional Data Flow, With Near-Zero **Propagation Delay**
- Low ON-State Resistance (ron) Characteristics  $(r_{on} = 5 \Omega \text{ Typ})$
- **Low Input/Output Capacitance Minimizes** Loading ( $C_{io(OFF)} = 9 pF Typ$ )
- **Data and Control Inputs Provide Undershoot** Clamp Diodes
- Low Power Consumption ( $I_{CC} = 70 \mu A Max$ )
- V<sub>CC</sub> Operating Range From 2.3 V to 3.6 V
- Data I/Os Support 0-V to 5-V Signaling Levels (0.8 V, 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V, 5 V)
- Control Inputs Can Be Driven by TTL or 5-V/3.3-V CMOS Outputs
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 250 mA Per **JESD 17**
- **ESD Performance Tested Per JESD 22** 
  - 2000-V Human-Body Model(A114-B, Class II)
  - 1000-V Charged-Device Model (C101)
- **Supports Digital Applications: Level** Translation, PCI Interface, USB Interface, Memory Interleaving, and Bus Isolation
- Ideal for Low-Power Portable Equipment

#### **DGG OR DGV PACKAGE** (TOP VIEW)

| _                 |    |    | L      |
|-------------------|----|----|--------|
| S0                | 1  | 56 | ] S1   |
| 1A1 [             | 2  | 55 | ] S2   |
| 1A2               | 3  | 54 | ] 1B1  |
| 2A1               | 4  | 53 | ] 1B2  |
| 2A2               | 5  | 52 | ] 2B1  |
| 3A1[              | 6  | 51 | ] 2B2  |
| 3A2[              | 7  | 50 | ] 3B1  |
| GND[              | 8  | 49 | GND    |
| 4A1               | 9  | 48 | ] 3B2  |
| 4A2[              | 10 | 47 | ] 4B1  |
| 5A1               | 11 | 46 | ] 4B2  |
| 5A2               | 12 | 45 | ] 5B1  |
| 6A1 [             | 13 | 44 | ] 5B2  |
| 6A2               | 14 | 43 | ] 6B1  |
| 7A1               | 15 | 42 | ] 6B2  |
| 7A2               | 16 | 41 | ] 7B1  |
| v <sub>cc</sub> [ | 17 | 40 | ] 7B2  |
| 8A1[              | 18 | 39 | ] 8B1  |
| GND[              | 19 | 38 | GND    |
| 8A2 [             | 20 | 37 | ] 8B2  |
| 9A1 [             | 21 | 36 | ] 9B1  |
| 9A2 [             | 22 | 35 | ] 9B2  |
| 10A1              | 23 | 34 | ] 10B1 |
| 10A2[             | 24 | 33 | ] 10B2 |
| 11A1              | 25 | 32 | ] 11B1 |
| 11A2[             | 26 | 31 | ] 11B2 |
| 12A1[             | 27 | 30 | ] 12B1 |
| 12A2[             | 28 | 29 | ] 12B2 |

#### DESCRIPTION/ORDERING INFORMATION

The SN74CB3T16212 is a high-speed TTL-compatible FET bus-exchange switch, with low ON-state resistance (r<sub>on</sub>), allowing for minimal propagation delay. The device fully supports mixed-mode signal operation on all data I/O ports by providing voltage translation that tracks V<sub>CC</sub>. The SN74CB3T16212 supports systems using 5-V TTL, 3.3-V LVTTL, and 2.5-V CMOS switching standards, as well as user-defined switching levels (see Figure 1).

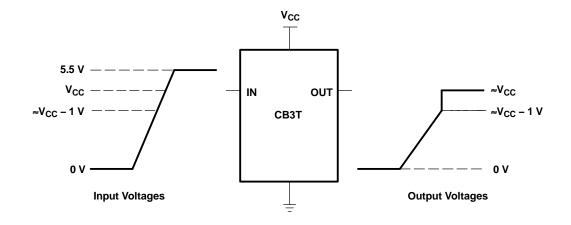
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Widebus is a trademark of Texas Instruments.

# 24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

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NOTE: If the input high-voltage ( $V_{IH}$ ) level is greater than or equal to  $V_{CC}$  – 1 V and less than or equal to 5.5 V, the output high-voltage ( $V_{OH}$ ) level is equal to approximately the  $V_{CC}$  voltage level.

Figure 1. Typical DC Voltage Translation Characteristics

The SN74CB3T16212 operates as a 24-bit bus switch or as a 12-bit bus exchange that provides data exchanging between four signal ports. The select (S0, S1, S2) inputs control the data path of the bus-exchange switch. When the bus-exchange switch is ON, the A port is connected to the B port, allowing bidirectional data flow between ports. When the bus-exchange switch is OFF, a high-impedance state exists between the A and B ports.

This device is fully specified for partial-power-down applications using I<sub>off</sub>. The I<sub>off</sub> feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down, each select input should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

#### ORDERING INFORMATION

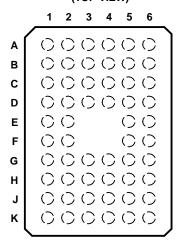
| T <sub>A</sub> | PACKAGE <sup>(1)</sup>              |               | PACKAGE <sup>(1)</sup> ORDERABLE PART NUMBER |           |  |
|----------------|-------------------------------------|---------------|----------------------------------------------|-----------|--|
|                | TSSOP - DGG                         | Tape and reel | SN74CB3T16212DGGR                            | CB3T16212 |  |
| –40°C to 85°C  | TVSOP – DGV Tape and reel           |               | SN74CB3T16212DGVR                            | KR212     |  |
| -40 C to 65 C  | VFBGA – GQL                         | Tape and reel | SN74CB3T16212GQLR                            | KR212     |  |
|                | VFBGA – ZQL (Pb-free) Tape and reel |               | SN74CB3T16212ZQLR                            | - KRZ1Z   |  |

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

## SN74CB3T16212 24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

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# GQL OR ZQL PACKAGE (TOP VIEW)



#### **TERMINAL ASSIGNMENTS**

|   | 1               | 2    | 3    | 4    | 5    | 6    |
|---|-----------------|------|------|------|------|------|
| Α | 1A2             | 1A1  | S0   | S1   | S2   | 1B1  |
| В | 3A1             | 2A2  | 2A1  | 1B2  | 2B1  | 2B2  |
| С | 4A1             | GND  | 3A2  | 3B1  | GND  | 3B2  |
| D | 5A2             | 4A2  | 5A1  | 4B2  | 4B1  | 5B1  |
| E | 6A2             | 6A1  |      |      | 5B2  | 6B1  |
| F | 7A1             | 7A2  |      |      | 7B1  | 6B2  |
| G | V <sub>CC</sub> | GND  | 8A1  | 8B1  | GND  | 7B2  |
| Н | 8A2             | 9A1  | 9A2  | 9B2  | 9B1  | 8B2  |
| J | 10A1            | 10A2 | 11A1 | 11B1 | 10B2 | 10B1 |
| K | 11A2            | 12A1 | 12A2 | 12B2 | 12B1 | 11B2 |

## **FUNCTION TABLE**

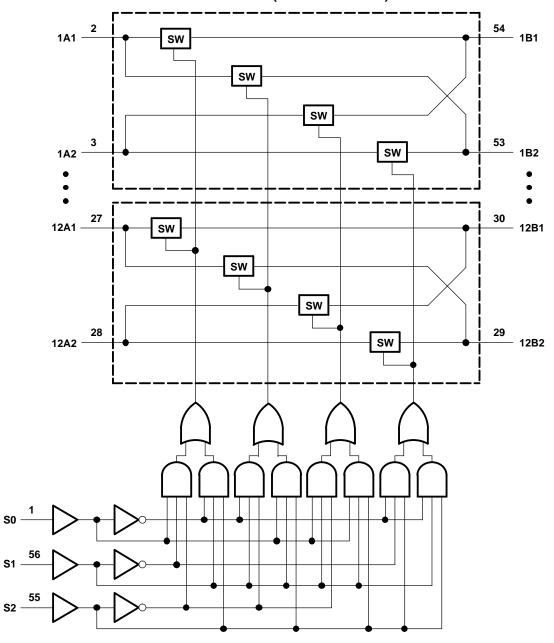
| INPUTS |    |    | INPUTS/0 | DUTPUTS | FUNCTION                               |
|--------|----|----|----------|---------|----------------------------------------|
| S2     | S1 | S0 | A1       | A2      | FUNCTION                               |
| L      | L  | L  | Z        | Z       | Disconnect                             |
| L      | L  | Н  | B1 port  | Z       | A1 port = B1 port                      |
| L      | Н  | L  | B2 port  | Z       | A1 port = B2 port                      |
| L      | Н  | Н  | Z        | B1 port | A2 port = B1 port                      |
| Н      | L  | L  | Z        | B2 port | A2 port = B2 port                      |
| Н      | L  | Н  | Z        | Z       | Disconnect                             |
| Н      | Н  | L  | B1 port  | B2 port | A1 port = B1 port<br>A2 port = B2 port |
| Н      | Н  | Н  | B2 port  | B1 port | A1 port = B2 port<br>A2 port = B1 port |

# 24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

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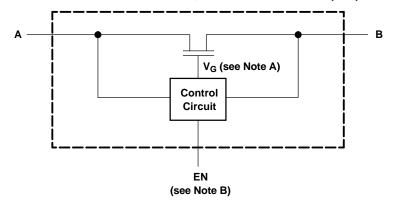
## **LOGIC DIAGRAM (POSITIVE LOGIC)**



## SN74CB3T16212 24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

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### SIMPLIFIED SCHEMATIC, EACH FET SWITCH (SW)



- A. Gate voltage ( $V_G$ ) is equal to approximately  $V_{CC}$  +  $V_T$  when the switch is ON and  $V_I > V_{CC} + V_T$ .
- B. EN is the internal enable signal applied to the switch.

## **ABSOLUTE MAXIMUM RATINGS**(1)

over free-air temperature range (unless otherwise noted)

|                   |                                                   |                      | MIN  | MAX  | UNIT |  |
|-------------------|---------------------------------------------------|----------------------|------|------|------|--|
| V <sub>CC</sub>   | Supply voltage range <sup>(2)</sup>               |                      | -0.5 | 7    | V    |  |
| V <sub>IN</sub>   | Control input voltage range <sup>(2)(3)</sup>     |                      | -0.5 | 7    | V    |  |
| V <sub>I/O</sub>  | Switch I/O voltage range <sup>(2)(3)(4)</sup>     |                      | -0.5 | 7    | V    |  |
| I <sub>IK</sub>   | Control input clamp current                       | V <sub>IN</sub> < 0  |      | -50  | mA   |  |
| I <sub>I/OK</sub> | I/O port clamp current                            | V <sub>I/O</sub> < 0 |      | -50  | mA   |  |
| I <sub>I/O</sub>  | ON-state switch current <sup>(5)</sup>            |                      |      | ±128 | mA   |  |
|                   | Continuous current through V <sub>CC</sub> or GND |                      |      | ±100 | mA   |  |
|                   |                                                   | DGG package          |      | 64   |      |  |
| $\theta_{JA}$     | Package thermal impedance (6)                     | DGV package          |      | 48   | °C/W |  |
|                   |                                                   | GQL/ZQL package      |      | 42   |      |  |
| T <sub>stg</sub>  | Storage temperature range                         |                      | -65  | 150  | °C   |  |

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to ground, unless otherwise specified.
- (3) The input and output volrage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (4)  $V_I$  and  $V_O$  are used to denote specific conditions for  $V_{I/O}$ .
- (5)  $I_1$  and  $I_0$  are used to denote specific conditions for  $I_{1/0}$ .
- (6) The package thermal impedance is calculated in accordance with JESD 51-7.

## RECOMMENDED OPERATING CONDITIONS(1)

|                  |                                                  |                                            | MIN | MAX | UNIT |
|------------------|--------------------------------------------------|--------------------------------------------|-----|-----|------|
| V <sub>CC</sub>  | Supply voltage                                   |                                            | 2.3 | 3.6 | V    |
| .,               | V <sub>IH</sub> High-level control input voltage | V <sub>CC</sub> = 2.3 V to 2.7 V           | 1.7 | 5.5 |      |
| VIH              |                                                  | $V_{CC}$ = 2.7 V to 3.6 V                  | 2   | 5.5 | V    |
| .,               | Low-level control input voltage                  | V <sub>CC</sub> = 2.3 V to 2.7 V           | 0   | 0.7 |      |
| $V_{IL}$         |                                                  | $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$ | 0   | 0.8 | V    |
| V <sub>I/O</sub> | Data input/output voltage                        |                                            | 0   | 5.5 | V    |
| T <sub>A</sub>   | Operating free-air temperature                   |                                            | -40 | 85  | °C   |

All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## SN74CB3T16212

## 24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER



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## **ELECTRICAL CHARACTERISTICS**(1)

| PAR                            | AMETER         | TEST CONDITION                                                                                   | MIN TYP <sup>(2)</sup>                             | MAX | UNIT |    |
|--------------------------------|----------------|--------------------------------------------------------------------------------------------------|----------------------------------------------------|-----|------|----|
| $V_{IK}$                       |                | $V_{CC} = 3 \text{ V, I}_{I} = -18 \text{ mA}$                                                   |                                                    |     | -1.2 | V  |
| $V_{OH}$                       |                | See Figures 3 and 4                                                                              |                                                    |     |      |    |
| I <sub>IN</sub>                | Control inputs | $V_{CC} = 3.6 \text{ V}, V_{IN} = 3.6 \text{ V} \text{ to } 5.5 \text{ V} \text{ or GND}$        |                                                    |     | ±10  | μΑ |
|                                |                |                                                                                                  | $V_{I} = V_{CC} - 0.7 \text{ V to } 5.5 \text{ V}$ |     | ±20  |    |
| $I_{\parallel}$                |                |                                                                                                  | $V_{I} = 0.7 \text{ V to } V_{CC} - 0.7 \text{ V}$ |     | -40  | μΑ |
|                                |                |                                                                                                  | $V_{I} = 0 \text{ to } 0.7 \text{ V}$              |     | ±5   |    |
| $I_{OZ}^{(3)}$                 |                | $V_{CC} = 3.6 \text{ V}, V_{I} = 0, V_{IN} = V_{CC} \text{ or GND}, V_{O} = 0$                   | to 5.5 V, Switch OFF                               |     | ±10  | μΑ |
| I <sub>off</sub>               |                | $V_{CC} = 0$ , $V_I = 0$ , $V_O = 0$ to 5.5 V                                                    |                                                    | 10  | μΑ   |    |
| _                              |                | $V_{CC} = 3.6 \text{ V}, V_{IN} = V_{CC} \text{ or GND}, I_{I/O} = 0,$                           | $V_I = V_{CC}$ or GND                              |     | 70   | ^  |
| I <sub>CC</sub>                |                | Switch ON or OFF                                                                                 | V <sub>I</sub> = 5.5 V                             |     | 70   | μΑ |
| $\Delta I_{CC}^{(4)}$          | Control inputs | $V_{CC}$ = 3 V to 3.6 V, One input at $V_{CC}$ – 0.6 V, C                                        | Other inputs at V <sub>CC</sub> or GND             |     | 300  | μΑ |
| C <sub>in</sub>                | Control inputs | $V_{CC} = 3.3 \text{ V}, V_{IN} = V_{CC} \text{ or GND}$                                         |                                                    | 4   |      | pF |
| C <sub>io(OFF</sub>            | )              | $V_{CC} = 3.3 \text{ V}, V_{IN} = V_{CC} \text{ or GND}, V_{I/O} = 5.5 \text{ V}, 3.0 \text{ m}$ | 3 V, or GND, Switch OFF                            | 9   |      | pF |
| _                              |                | V 22VVV V ar CND Cuital ON                                                                       | V <sub>I/O</sub> = 5.5 V or 3.3 V                  | 8   |      |    |
| C <sub>io(ON)</sub>            |                | $V_{CC} = 3.3 \text{ V}, V_{IN} = V_{CC} \text{ or GND, Switch ON}$                              | $V_{I/O} = GND$                                    | 23  |      | pF |
|                                |                | V 22V TVD at V 25 V V 2                                                                          | I <sub>O</sub> = 24 mA                             | 5   | 9.5  |    |
| <b>.</b> (5)                   |                | $V_{CC} = 2.3 \text{ V}, \text{ TYP at } V_{CC} = 2.5 \text{ V}, V_{I} = 0$                      | I <sub>O</sub> = 16 mA                             | 5   | 9.5  | 0  |
| r <sub>ON</sub> <sup>(5)</sup> |                | V 2VV 0                                                                                          | I <sub>O</sub> = 64 mA                             | 5   | 8.5  | Ω  |
|                                |                | $V_{CC} = 3 \text{ V}, V_{I} = 0$                                                                | I <sub>O</sub> = 32 mA                             | 5   | 8.5  |    |

- $V_{IN}$  and  $I_{IN}$  refer to control inputs.  $V_I$ ,  $V_O$ ,  $I_I$ , and  $I_O$  refer to data pins. All typical values are at  $V_{CC}$  = 3.3 V (unless otherwise noted),  $T_A$  = 25°C.
- For I/O ports, the parameter  $I_{OZ}$  includes the input leakage current. This is the increase in supply current for each input that is at the specified TTL voltage level, rather than  $V_{CC}$  or GND.
- Measured by the voltage drop between A and B terminals at the indicated current throught the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

## **SWITCHING CHARACTERISTICS**

over operating free-air temperature range (unless otherwise noted) (see Figure 2)

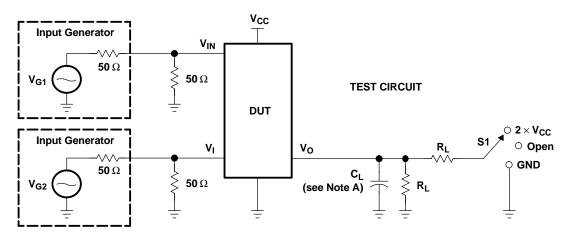
| PARAMETER                      | FROM<br>(INPUT) | TO     | $V_{CC}$ = 2.5 V $\pm$ 0.2 V |      | $V_{CC}$ = 3.3 V $\pm$ 0.3 V |      | UNIT |
|--------------------------------|-----------------|--------|------------------------------|------|------------------------------|------|------|
|                                | (INPUT)         |        |                              | MAX  |                              |      |      |
| t <sub>pd</sub> <sup>(1)</sup> | A or B          | B or A |                              | 0.15 |                              | 0.25 | ns   |
| t <sub>pd(s)</sub>             | S               | A      | 1                            | 15.5 | 1                            | 11.5 | ns   |
| t <sub>en</sub>                | S               | В      | 1                            | 15   | 1                            | 12   | ns   |
| t <sub>dis</sub>               | S               | В      | 1                            | 12   | 1                            | 10.5 | ns   |

(1) The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capaitance, when driven by an ideal voltage source (zero output impedance).

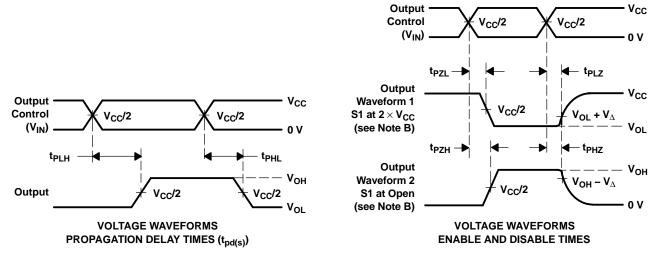
## 24-BIT FET BUS-EXCHANGE SWITCH, 2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

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#### PARAMETER MEASUREMENT INFORMATION



| TEST                               | V <sub>CC</sub>   | S1                | R <sub>L</sub> | VI           | CL    | $V_{\Delta}$ |
|------------------------------------|-------------------|-------------------|----------------|--------------|-------|--------------|
| t <sub>pd(s)</sub>                 | 2.5 V $\pm$ 0.2 V | Open              | 500 Ω          | 3.6 V or GND | 30 pF |              |
| -pu(s)                             | 3.3 V $\pm$ 0.3 V | Open              | <b>500</b> Ω   | 5.5 V or GND | 50 pF |              |
| t <sub>PLZ</sub> /t <sub>PZL</sub> | 2.5 V $\pm$ 0.2 V | 2×V <sub>CC</sub> | 500 Ω          | GND          | 30 pF | 0.15 V       |
| TPLZ/TPZL                          | 3.3 V $\pm$ 0.3 V | $2 \times V_{CC}$ | 500 Ω          | GND          | 50 pF | 0.3 V        |
| 4 /4                               | 2.5 V ± 0.2 V     | Open              | 500 Ω          | 3.6 V        | 30 pF | 0.15 V       |
| t <sub>PHZ</sub> /t <sub>PZH</sub> | 3.3 V $\pm$ 0.3 V | Open              | <b>500</b> Ω   | 5.5 V        | 50 pF | 0.3 V        |



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq$  2.5 ns,  $t_f \leq$  2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G. tpLH and tpHL are the same as tod(s). The tpd propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
- H. All parameters and waveforms are not applicable to all devices.

Figure 2. Test Circuit and Voltage Waveforms



## TYPICAL CHARACTERISTICS

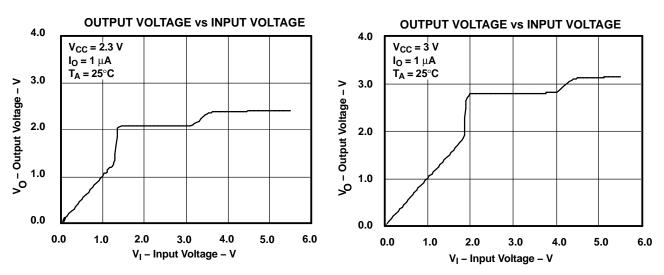
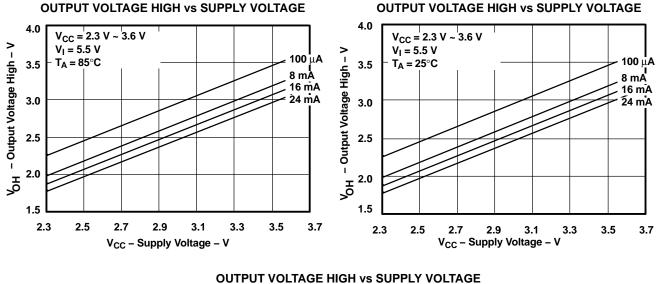


Figure 3. Data Output Voltage vs Data Input Voltage



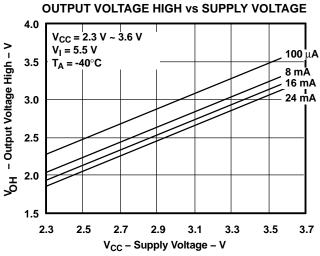


Figure 4. V<sub>OH</sub> Values





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#### **PACKAGING INFORMATION**

| Orderable Device  | Status <sup>(1)</sup> | Package<br>Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan <sup>(2)</sup> | Lead/Ball Finish | MSL Peak Temp <sup>(3)</sup> |
|-------------------|-----------------------|-----------------|--------------------|------|----------------|-------------------------|------------------|------------------------------|
| SN74CB3T16212DGGR | ACTIVE                | TSSOP           | DGG                | 56   | 2000           | Pb-Free<br>(RoHS)       | CU NIPDAU        | Level-1-250C-UNLIM           |
| SN74CB3T16212DGVR | ACTIVE                | TVSOP           | DGV                | 56   | 2000           | Pb-Free<br>(RoHS)       | CU NIPDAU        | Level-1-250C-UNLIM           |
| SN74CB3T16212ZQLR | ACTIVE                | VFBGA           | ZQL                | 56   | 1000           | Pb-Free<br>(RoHS)       | SNAGCU           | Level-1-260C-UNLIM           |

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

None: Not yet available Lead (Pb-Free).

**Pb-Free** (**RoHS**): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

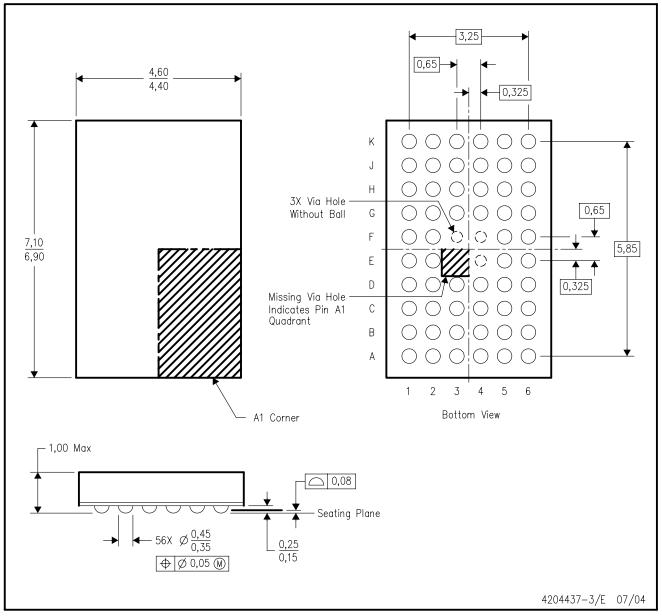
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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## ZQL (R-PBGA-N56)

## PLASTIC BALL GRID ARRAY



NOTES:

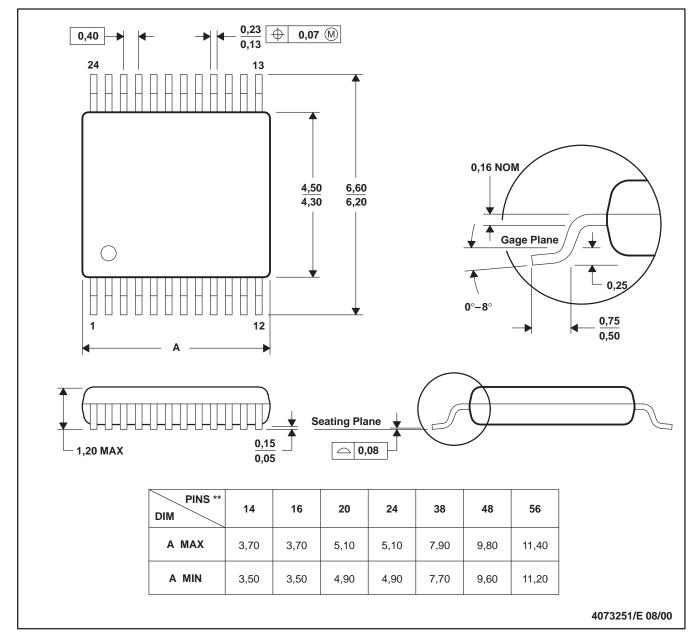
- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-225 variation BA.
- D. This package is lead-free. Refer to the 56 GQL package (drawing 4200583) for tin-lead (SnPb).



## DGV (R-PDSO-G\*\*)

## **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194

## DGG (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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